

# DS1267 **Dual Digital Potentiometer Chip**

#### www.dalsemi.com

#### **FEATURES**

- Ultra-low power consumption, quiet, pumpless design
- Two digitally controlled, 256-position potentiometers
- Serial port provides means for setting and reading both potentiometers
- Resistors can be connected in series to provide increased total resistance
- 14-pin DIP, 16-pin SOIC, 20-pin TSSOP packages
- Resistive elements are temperature compensated to ±0.3 LSB relative linearity
- Standard resistance values:
  - DS1267-10 ~ 10 kΩ
  - DS1267-50 ~ 50 kΩ
  - DS1267-100 ~ 100 kΩ
- Operating Temperature Range:
  - Industrial: -40°C to +85°C

#### PIN DESCRIPTIONS

L0, L1 - Low End of Resistor H0, H1 - High End of Resistor

W0, W1 - Wiper Terminal of Resistor

V<sub>B</sub> - Substrate Bias Voltage

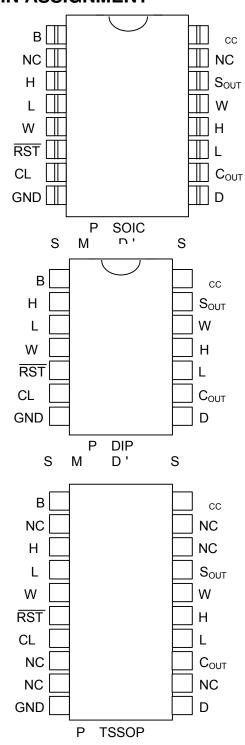
 $S_{OUT}$  - Stacked Configuration Output

RST - Serial Port Reset Input
DQ - Serial Port Data Input
CLK - Serial Port Clock Input
COUT - Cascade Port Output
VCC - +5 Volt Supply

GND - Ground

NC - No Internal Connection

#### **PIN ASSIGNMENT**



#### DESCRIPTION

The DS1267 Dual Digital Potentiometer Chip consists of two digitally controlled, solid-state potentiometers. Each potentiometer is composed of 256 resistive sections. Between each resistive section and both ends of the potentiometer are tap points which are accessible to the wiper. The position of the wiper on the resistive array is set by an 8-bit value that controls which tap point is connected to the wiper output. Communication and control of the device are accomplished via a 3-wire serial port interface. This interface allows the device wiper position to be read or written.

Both potentiometers can be connected in series (or stacked) for an increased total resistance with the same resolution. For multiple-device, single-processor environments, the DS1267 can be cascaded or daisy-chained. This feature provides for control of multiple devices over a single 3-wire bus.

The DS1267 is offered in three standard resistance values which include 10, 50, and 100-kohm versions. Available packages for the device include a 14-pin DIP, 16-pin SOIC, and 20-pin TSSOP.

#### **OPERATION**

The DS1267 contains two 256-position potentiometers whose wiper positions are set by an 8-bit value. These two 8-bit values are written to a 17-bit I/O shift register that is used to store the two wiper positions and the stack select bit when the device is powered. A block diagram of the DS1267 is presented in Figure 1.

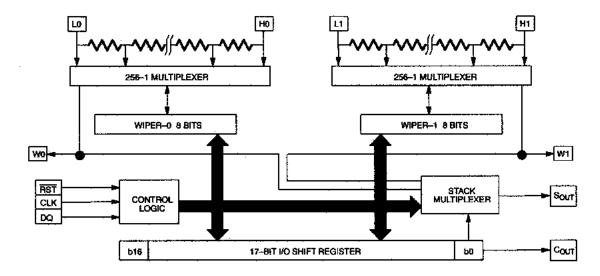
Communication and control of the DS1267 are accomplished through a 3-wire serial port interface that drives an internal control logic unit. The 3-wire serial interface consists of the three input signals:  $\overline{\text{RST}}$ , CLK, and DQ.

The  $\overline{\text{RST}}$  control signal is used to enable the 3-wire serial port operation of the device. The chip is selected when  $\overline{\text{RST}}$  is high;  $\overline{\text{RST}}$  must be high to begin any communication to the DS1267. The CLK signal input is used to provide timing synchronization for data input and output. The DQ signal line is used to transmit potentiometer wiper settings and the stack select bit configuration to the 17-bit I/O shift register of the DS1267.

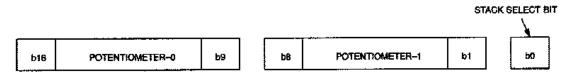
Figure 9(a) presents the 3-wire serial port protocol. As shown, the 3-wire port is inactive when the  $\overline{\text{RST}}$  signal input is low. Communication with the DS1267 requires the transition of the  $\overline{\text{RST}}$  input from a low state to a high state. Once the 3-wire port has been activated, data is entered into the part on the low to high transition of the CLK signal inputs. Three-wire serial timing requirements are provided in the timing diagrams of Figure 9(b)-(c).

Data written to the DS1267 over the 3-wire serial interface is stored in the 17-bit I/O shift register (see Figure 2). The 17-bit I/O shift register contains both 8-bit potentiometer wiper position values and the stack select bit. The composition of the I/O shift register is presented in Figure 2. Bit 0 of the I/O shift register contains the stack select bit, which will be discussed in the section entitled "Stacked Configuration." Bits 1 through 8 of the I/O shift register contain the potentiometer-1 wiper position value. Bit 1 contains the MSB of the wiper setting for potentiometer-1 and bit 8 the LSB for the wiper setting. Bits 9 through 16 of the I/O shift register contain the value of the potentiometer-0 wiper position, with the MSB for the wiper position occupying bit 9 and the LSB bit 16.

#### **DS1267 BLOCK DIAGRAM**



#### I/O SHIFT REGISTER



17-BIT I/O SHIFT REGISTER

Transmission of data always begins with the stack select bit followed by the potentiometer-1 wiper position value and lastly the potentiometer-0 wiper position value.

When wiper position data is to be written to the DS1267, 17 bits (or some integer multiple) of data should always be transmitted. Transactions which do not send a complete 17-bits (or multiple) will leave the register incomplete and possibly an error in the desired wiper positions.

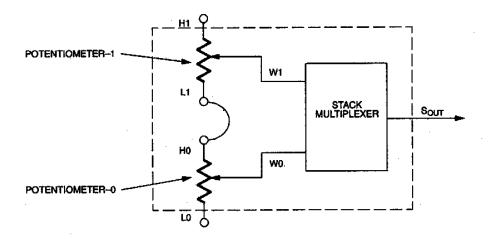
After a communication transaction has been completed, the  $\overline{\text{RST}}$  signal input should be taken to a low state to prevent any inadvertent changes to the device shift register. Once  $\overline{\text{RST}}$  has reached a low state, the contents of the I/O shift register are loaded into the respective multiplexers for setting wiper position. A new wiper position will only engage after a  $\overline{\text{RST}}$  transition to the inactive state. On device power-up the DS1267 wiper positions will be set at 50% of the total resistance or binary value 1000 0000.

#### STACKED CONFIGURATION

The potentiometers of the DS1267 can be connected in series as shown in Figure 3. This is referred to as the stacked configuration. The stacked configuration allows the user to double the total end-to-end resistance of the part and the number of steps to 512 (or 9 bits of resolution).

The wiper output for the combined stacked potentiometer will be taken at the  $S_{OUT}$  pin, which is the multiplexed output of the wiper of potentiometer-0 (W0) or potentiometer-1 (W1). The potentiometer wiper selected at the  $S_{OUT}$  output is governed by the setting of the stack select bit (bit 0) of the 17-bit I/O shift register. If the stack select bit has value 0, the multiplexed output,  $S_{OUT}$ , will be that of the potentiometer-0 wiper. If the stack select bit has value 1, the multiplexed output,  $S_{OUT}$ , will be that of the potentiometer-1 wiper.

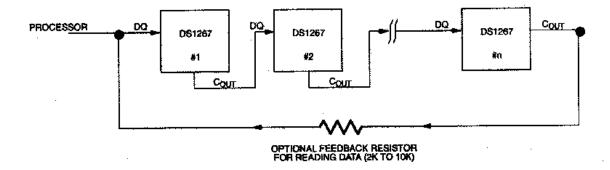
#### STACKED CONFIGURATION



#### CASCADE OPERATION

A feature of the DS1267 is the ability to control multiple devices from a single processor. Multiple DS1267s can be linked or daisy-chained as shown in Figure 4. As a data bit is entered into the I/O shift register of the DS1267 a bit will appear at the  $C_{OUT}$  output within a maximum delay of 50 nanoseconds. The stack select bit of the DS1267 will always be the first out the part at the beginning of a transaction. Additionally the  $C_{OUT}$  pin is always active regardless of the state of  $\overline{RST}$ . This allows one to read the I/O shift register without changing its value.

#### CASCADING MULTIPLE DEVICES



The C<sub>OUT</sub> output of the DS1267 can be used to drive the DQ input of another DS1267. When connecting multiple devices, the total number of bits transmitted is always 17 times the number of DS1267s in the daisy chain.

An optional feedback resistor can be placed between the  $C_{OUT}$  terminal of the last device and the first DS1267 DQ input, thus allowing the controlling processor to read as well as write data or circularly clock data through the daisy chain. The value of the feedback or isolation resistor should be in the range from 1 to 10 kohms.

When reading data via the  $C_{OUT}$  pin and isolation resistor, the DQ line is left floating by the reading device. When  $\overline{RST}$  is driven high, bit 17 is present on the  $C_{OUT}$  pin, which is fed back to the input DQ pin through the isolation resistor. When the CLK input transitions low to high, bit 17 is loaded into the first position of the I/O shift register and bit 16 becomes present on  $C_{OUT}$  and DQ of the next device. After 17 bits (or 17 times the number of DS1267s in the daisy chain), the data has shifted completely around and back to its original position. When  $\overline{RST}$  transitions to the low state to end data transfer, the value (the same as before the read occurred) is loaded into the wiper-0, wiper-1, and stack select bit I/O register.

#### ABSOLUTE AND RELATIVE LINEARITY

Absolute linearity is defined as the difference between the actual measured output voltage and the expected output voltage. Figure 5 presents the test circuit used to measure absolute linearity. Absolute linearity is given in terms of a minimum increment or expected output when the wiper is moved one position. In the case of the test circuit, a minimum increment (MI) or one LSB would equal 10/512 volts. The equation for absolute linearity is given as follows:

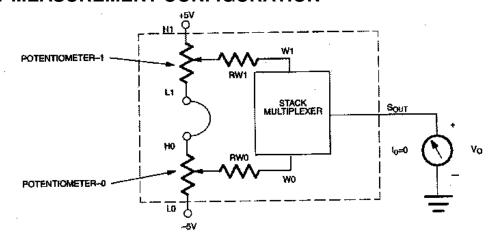
(1) ABSOLUTE LINEARITY  $AL=\{V_0 \text{ (actual)} - V_0 \text{ (expected)}\}/MI$ 

Relative Linearity is a measure of error between two adjacent wiper position points and is given in terms of MI by equation (2).

(2) RELATIVE LINEARITY  $RL=\{V_{O}(n+1) - V_{O}(n)\}/MI$ 

Figure 6 is a plot of absolute linearity and relative linearity versus wiper position for the DS1267 at 25 $^{\circ}$ C. The specification for absolute linearity of the DS1267 is  $\pm 0.75$  MI typical. The specification for relative linearity of the DS1267 is  $\pm 0.3$  MI typical.

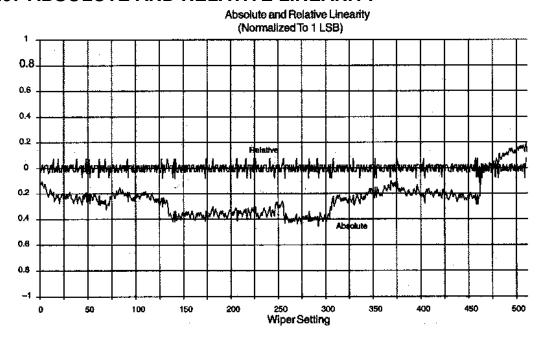
#### LINEARITY MEASUREMENT CONFIGURATION



#### NOTE:

In this setup, a  $\pm 2\%$  delta in total resistance R0 to R1 would cause a  $\pm 2.5$  MI error.

#### **DS1267 ABSOLUTE AND RELATIVE LINEARITY**



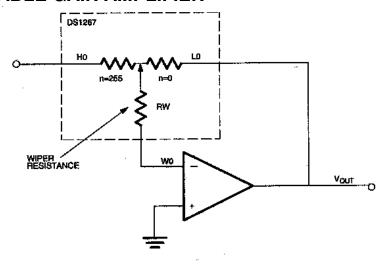
#### TYPICAL APPLICATION CONFIGURATIONS

Figures 7 and 8 show two typical application configurations for theDS1267. By connecting the wiper terminal of the part to a high-impedance load, the effects of the wiper resistance is minimized, since the wiper resistance can vary from 400 to 1000ohms depending on wiper voltage. Figure 7 presents the device connected in an inverting variable gain amplifier. The gain of the circuit on Figure 7 is given by the following equation:

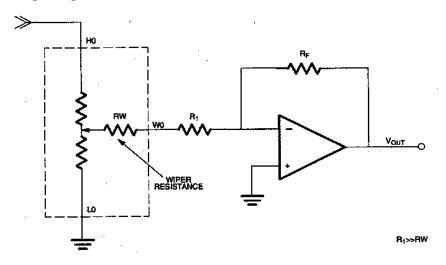
Av = -n/(255-n); where n = 0 to 255

Figure 8 shows the device operating in a fixed gain attenuator where the potentiometer is used to attenuate an incoming signal. Note the resistance R1 is chosen to be much greater than the wiper resistance to minimize its effect on circuit gain.

### **INVERTING VARIABLE GAIN AMPLIFIER**



## **FIX GAIN ATTENUATOR**



#### **ABSOLUTE MAXIMUM RATINGS\***

#### RECOMMENDED DC OPERATING CONDITIONS

°C °C CC **PARAMETER SYMBOL** MAX **UNITS NOTES MIN TYP**  $V_{CC}$ 4.5 5.5 V 1 Supply Voltage Input Logic 1  $V_{IH}$ 2.0  $V_{CC}+0.5$ V 1 V Input Logic 0  $V_{\rm IL}$ -0.5 +0.81 Substrate Bias  $V_{B}$ -5.5 **GND** V 1 L,H,W V 2 **Resistor Inputs**  $V_B-0.5$  $V_{CC}+0.5$ 

DC ELECTRICAL CHARACTERISTICS °C °C CC									
PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES			
Supply Current	$I_{CC}$		22	650	μA	9			
Input Leakage	$I_{LI}$	-1		+1	μΑ				
Wiper Resistance	R <sub>W</sub>		400	1000	Ω	5			
Wiper Current	$I_{\mathrm{W}}$			1	mA				
Output Leakage	$I_{LO}$	-1		+1	μΑ				
Logic 1 Output @ 2.4V	I <sub>OH</sub>	-1			mA	7			
Logic 0 Output @ 0.4V	I <sub>OL</sub>			4	mA	7			
Standby Current	I <sub>STBY</sub>		22		μΑ	5			

<sup>\*</sup> This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

<b>ANALOG RESISTOR CHA</b>	°C	°C c	C			
PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
End-to-End Resistor Tolerance		-20		+20	%	10
Absolute Linearity			±.75		LDB	3
Relative Linearity			±0.3		LDB	4
-3 dB Cutoff Frequency	F <sub>CUTOFF</sub>				Hz	6
Temperature Coefficient			750		ppm/C	

**CAPACITANCE** T<sub>A</sub> °C

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Input Capacitance	$C_{IN}$			5	pF	
Output Capacitance	C <sub>OUT</sub>			7	pF	

AC ELECTRICAL CHARAC	CTERISTIC	<u>CS</u>	°C	°C	CC
DADAMETED	SVMROI	MIN	TVD	MAY	IIN

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
CLK Frequency	$f_{CLK}$	DC		10	MHz	8
Width of CLK Pulse	t <sub>CH</sub>	50			ns	8
Data Setup Time	t <sub>DC</sub>	30			ns	8
Data Hold Time	t <sub>CDH</sub>	10			ns	8
Propagation Delay Time Low to High Level Clock to Output	$t_{PLH}$			50	ns	8
Propagation Delay Time High to Low Level	t <sub>PHL</sub>			50	ns	8
RST High to Clock Input High	t <sub>CC</sub>	50			ns	8
RST Low to Clock Input High	t <sub>HLT</sub>	50			ns	8
RST Inactive	t <sub>RLT</sub>	125			ns	8
CLK Rise Time, CLK Fall Time	$t_{CR}$			50	ns	8

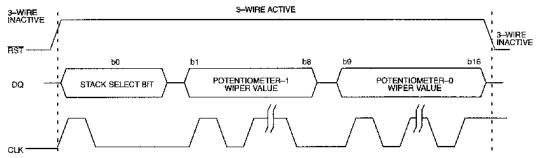
#### **NOTES:**

- 1. All voltages are referenced to ground.
- 2. Resistor inputs cannot exceed the substrate bias voltage, Vb, in the negative direction.
- 3. Absolute linearity is used to determine wiper voltage versus expected voltage as determined by wiper position. Device test limits ±1.6 LSB.

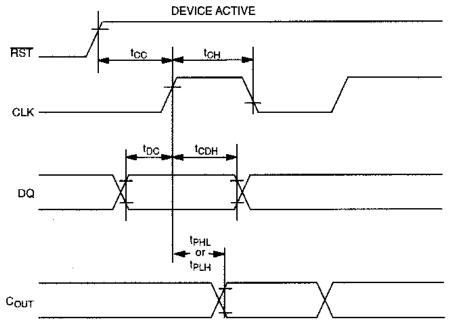
- 4. Relative linearity is used to determine the change in voltage between successive tap positions. Device test limits ±0.5 LSB.
- 5. Typical values are for  $T_A = 25$ °C and nominal supply voltage.
- 6. -3 dB cutoff frequency characteristics for the DS1267 depend on potentiometer total resistance: DS1267-010: 1 MHz; DS1267-050: 200 kHz; DS1267-100: 100 kHz.
- 7.  $C_{OUT}$  is active regardless of the state of  $\overline{RST}$ .
- 8. See Figure 9(a), (b), and (c).
- 9. See Figure 11.
- 10. Valid at 25°C only.

#### **TIMING DIAGRAMS**

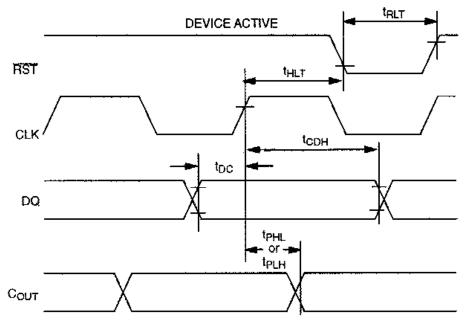
#### (A) 3-WIRE SERIAL INTERFACE GENERAL OVERVIEW



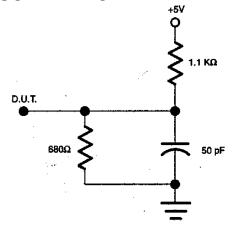
#### (B) START OF COMMUNICATION TRANSACTION



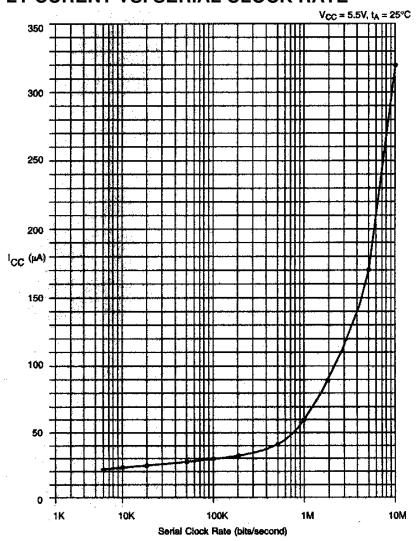
## (C) END OF COMMUNICATION TRANSACTION



## **DIGITAL OUTPUT LOAD SCHEMATIC**



## **TYPICAL SUPPLY CURENT VS. SERIAL CLOCK RATE**









A/LIATIC NIC

PRODUCTS

SOLUTION:

DESIGN

A PPNOTES

SUPPOR

Βl

COMPA

**MEMBERS** 

#### **DS1267**

#### **Part Number Table**

#### Notes:

- 1. See the DS1267 QuickView Data Sheet for further information on this product family or download the DS1267 full data sheet (PDF, 328kB).
- 2. Other options and links for purchasing parts are listed at: http://www.maxim-ic.com/sales.
- 3. Didn't Find What You Need? Ask our applications engineers. Expert assistance in finding parts, usually within one business day.
- 4. Part number suffixes: T or T&R = tape and reel; + = RoHS/lead-free; # = RoHS/lead-exempt. More: See full data sheet or Part Naming Conventions.
- 5. \* Some packages have variations, listed on the drawing. "PkgCode/Variation" tells which variation the product uses.

Part Number	Notes	Free Sample	Buy Direct	Package: TYPE PINS SIZE  DRAWING CODE/VAR *	Temp	RoHS/Lead-Free? Materials Analysis
DS1267-050+	50kohms			PDIP;14 pin;300 Dwg: 56-G5005-001A (PDF) Use pkgcode/variation: P14+4*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis
DS1267-010	10kohms			PDIP;14 pin;300 Dwg: 56-G5005-001A (PDF) Use pkgcode/variation: P14-4*	-40C to +85C	RoHS/Lead-Free: No Materials Analysis
DS1267-050	50kohms			PDIP;14 pin;300 Dwg: 56-G5005-001A (PDF) Use pkgcode/variation: P14-4*	-40C to +85C	RoHS/Lead-Free: No Materials Analysis
DS1267-100	100kohms			PDIP;14 pin;300 Dwg: 56-G5005-001A (PDF) Use pkgcode/variation: P14-4*	-40C to +85C	RoHS/Lead-Free: No Materials Analysis
DS1267-100+	100kohms			PDIP;14 pin;300 Dwg: 56-G5005-001A (PDF) Use pkgcode/variation: P14+4*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis
DS1267-010+	10kohms			PDIP;14 pin;300 Dwg: 56-G5005-001A (PDF) Use pkgcode/variation: P14+4*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis
DS1267S-010+	10kohms			SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16+3*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis

DS1267S-010+T&R	10kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16+3*	-40C to +85C RoHS/Lead-Free: Yes Materials Analysis
DS1267S-050+	50kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16+3*	-40C to +85C RoHS/Lead-Free: Yes Materials Analysis
DS1267S-050+T&R	50kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16+3*	-40C to +85C RoHS/Lead-Free: Yes Materials Analysis
DS1267S-100+	100kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16+3*	-40C to +85C RoHS/Lead-Free: Yes Materials Analysis
DS1267S-100+T&R	100kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16+3*	-40C to +85C RoHS/Lead-Free: Yes Materials Analysis
DS1267S-100/T&R	100kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16-3*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267S-050/T&R	50kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16-3*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267S-010/T&R	10kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16-3*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267S-010	10kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16-3*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267S-050	50kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16-3*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267S-100	100kohms	SOIC;16 pin;300 Dwg: 56-G4009-001B (PDF) Use pkgcode/variation: W16-3*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267E-10		TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20-1*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267E-50		TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20-1*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267E-100	100kohms	TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20-1*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267E-10/T&R		TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20-1*	-40C to +85C RoHS/Lead-Free: No Materials Analysis
DS1267E-100/T&R	100kohms	TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20-1*	-40C to +85C RoHS/Lead-Free: No Materials Analysis

DS1267E-50/T&R			TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20-1*	-40C to +85C	RoHS/Lead-Free: No Materials Analysis
DS1267E-50+T&R			TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20+1*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis
DS1267E-50+			TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20+1*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis
DS1267E-100+T&R	100kohms		TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20+1*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis
DS1267E-100+	100kohms		TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20+1*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis
DS1267E-10+T&R			TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20+3*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis
DS1267E-10+			TSSOP;20 pin;173 Dwg: 56-G2010-000B (PDF) Use pkgcode/variation: U20+3*	-40C to +85C	RoHS/Lead-Free: Yes Materials Analysis
DS1267-50 DICE				-40C to +85C	RoHS/Lead-Free: No

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